

Notice of References Cited	Application/Control No. 10/716,672	Applicant(s)/Patent Under Reexamination HARADA ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-4,992,559	02-1991	Kathirgamanathan et al.	549/65
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	K	US-			
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NON-PATENT DOCUMENTS

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